## Notice of References Cited Application/Control No. 09/841,774 Examiner Matsuichiro Shimizu Applicant(s)/Patent Under Reexamination CHAN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,765,484	07-2004	Eagleson et al.	340/505
	В	US-6,539,050	03-2003	Lee et al.	375/146
	O	US-5,490,079	02-1996	Sharpe et al.	705/418
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	1	US-			
	J	US-			
	K	US-			
	L	US-		·	
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					-
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.